TOSHIBA Bi-CMOS Integrated Circuit Silicon Monolithic

TB2104F

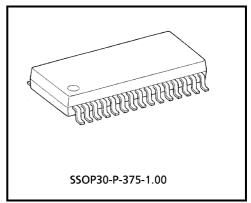
VFD Driver

The TB2104F is a VFD (fluorescent display tube) driver IC implemented by the Bi–CMOS process.

The logic section is configured with CMOS transistors, and the high voltage tolerant output driver section is configured with bipolar transistors.

Features

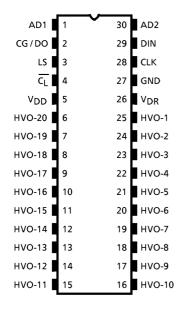
- Incorporates a shift register, latch, and driver capable of handling 20 bits of data.
- The output driver comes with an active pull-down, so it can function as a VFD grid, anode driver.
- Three serial data lines are used to input display data.
- The data receiver section can also accept general-purpose serial data and T-BUS (TOSHIBA semiconductor bus).
- In serial data mode, multiple drivers can be cascaded to expand the handling capacity in 20bit increments.

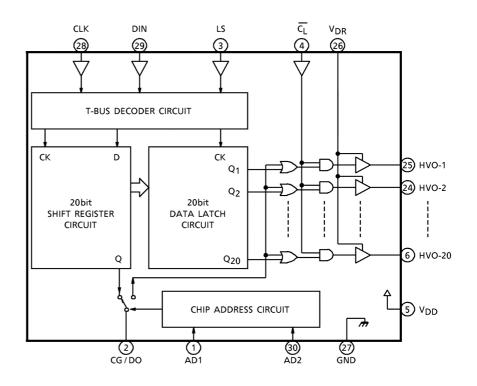


Weight: 0.7g (typ.)

Pin Connection

Block Diagram



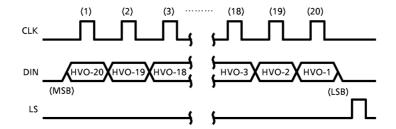


Pin Function

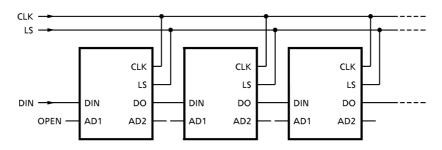
Pin No.	Symbol	Pin Name	Function And Operation	Remarks
1	AD1			3-value
30	AD2	Address setting input	Chip select / address setting inputs When using in serial mode, keep AD1 and AD2 "open". In other settings than "open", it becomes T–BUS mode and addresses up to 8 kinds can be set.	input 10k0
3	LS	Strobe input	Serial data input terminals	
28	CLK	Clock input	Inputs display data through the DIN terminal synchronizing with rise of CLK input.	CMOS
29	DIN	Data input	Display data are updated when inputting "H" level into LS terminal after completing data input. In T–BUS mode, LS terminal becomes "period" input.	input
2	CG / DO	Lamp test input and data output	 Lamp test input terminal and data output terminal In serial mode (AD1 = AD2 = open), this terminal serves as the serial data output terminal and enables cascade connection of driver IC. In T-BUS mode, this terminal serves as the lamp test input and is able to use all the driver outputs (HVO-1~-20) at "H" level by inputting "H" level signal. During the normal operation in T-BUS mode, use this terminal by fixing at "L" level. 	CMOS input / CMOS output built in pull–down resistor 20kΩ
4	C _L	Clear input	Driver off (blanking) input terminal All the driver outputs are fixed at "L" level when "L" level signal is input. When "H" level signal is input, it becomes the normal mode.	CMOS input built in pull-up resistor 20kΩ
5	V _{DD}	Logic unit power supply		
26	V _{DR}	Drive unit power supply	Power supply and GND terminals	_
27	GND	Ground		
25 24 23 :: 8 7 6	HVO-1 HVO-2 HVO-3 HVO-18 HVO-19 HVO-20	Driver output	High-tension driver output terminal Equivalent circuit Output DATA HVO	_

Explanation Of Operation

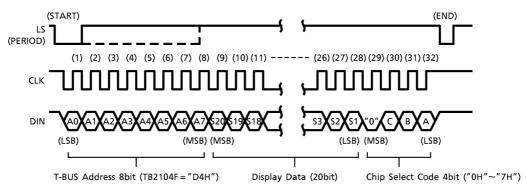
- 1. Serial data receiver circuit
 - The serial data receiver circuit can be changed over to operate in the serial mode or the T–BUS mode by switching, the AD1 / AD2 terminals.
 - In T–BUS mode, the AD1 / AD2 terminals become the chip select code inputs and it becomes possible to connect up to 8 drivers on the same bus line.
 - 1) Input data format in serial data mode (AD1 = AD2 = "open")



- Display data are updated when data for 20 bits are input from MSB side (HVO-20), synchronizing with rise of CLK signal and LS input is set to "H" level after inputting data.
- When increasing driver ICs, connect them through cascade connection as shown below:



2. Input data format in T-BUS mode



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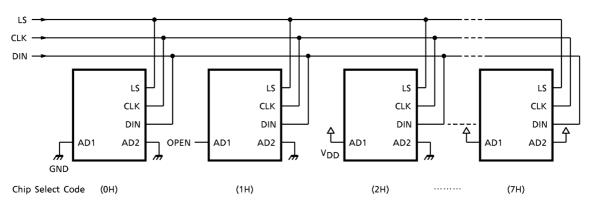
- In T-BUS mode, start data transmission with the LS terminal (period) set at "L" level.
 Thereafter, send address data 8 bits, display data 20 bits, and chip select code 4 bits, synchronizing with rise of CLK signal.
- · After sending data, set the LS terminal to "L" level again and terminate the data sending.
- On a driver IC when chip select code agrees with chip select code by AD1 / AD2, display data are updated at fall of LS signal.
- When increasing driver ICs, it is possible to connect up to 8 ICs on the same bus line in combination with AD1 / AD2.
- T-BUS address of the TB2104F is "D4H".
- When data are transferred using T-BUS address "00H", the data can be input to all the driver ICs on the bus line independently of chip select codes ("0H"~"7H"). (This function can be used for power on reset.)

3. AD1 / AD2 input and chip select codes

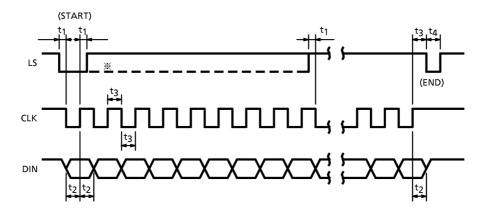
AD1 / AD2 input are 3-value level inputs and 9 kinds (3×3) of codes can be set.

AD1	AD2	Α	В	С	Chip Select Code	Mode	
V_{IH}		1	1	1	"7H"		
V _{IM}	V _{IH}	0	1	1	"6H"	T-BUS	
V _{IL}		1	0	1	"5H"		
V _{IH}	V _{IM}	0	0	1	"4H"		
V _{IM}		_	_	_	_	Serial	
V _{IL}		1	1	0	"3H"		
V _{IH}		0	1	0	"2H"	T-BUS	
V _{IM}	V _{IL}	1	0	0	"1H"	1-003	
V _{IL}		0	0	0	"0H"		

4. Example of extension of driver ICs in T-BUS mode chip select code



5. T-BUS mode timing chart



- $f_{CLK} \le 500 kHz$
- $t_1 \ge 0.2 \mu s, t_2 \ge 0.2 \mu s$
- $t_3 \ge 1.0 \mu s, t_4 \ge 1.0 \mu s$

Cautions for use

- Therefore, multiple driver outputs may possibly become "H" level simultaneously after the power is turned
 on.
 - (In this case, the allowable power dissipation of a device using this IC may possible be exceeded, destroying the device.)
- In order to avoid this, while keeping the clear terminal (\overline{CL}) at "L" level, rise the power supply for the logic unit (VDD) and then, that for the drivers (VDR), reset all the contents of the data latch ("L" level) by serial data, and initialize the driver outputs.

Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit	
Supply voltage	V_{DD}	-0.3~7.0	V	
Input voltage	V _{IN}	-0.3~V _{DD} +0.3	V	
Driver voltage	V_{DR}	V _{DD} ~60	V	
Driver current	I _{DR}	50	mA	
Power dissipation	P _D (Note)	800	mW	
Operating temperature	T _{opr}	-40~85	°C	
Storage temperature	T _{stg}	-55~150	°C	

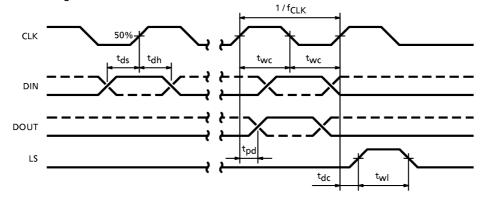
(Note) In case it is used at more than Ta = 25°C, it is considered by reducing 6.4mW each 1°C.

Electrical Characteristics (unless otherwise specified, V_{DD} = 5V, V_{DR} = 50V, Ta = 25°C)

Characteristic		Symbol	Test Cir– cuit	Test Condition		Min.	Тур.	Max.	Unit
Operating supply voltage (1)		V_{DD}	_	Logic unit		4.5	5.0	5.5	V
Operating supply voltage (2)		V_{DR}	_	Driver unit		10	~	50	V
Operating supply current (1)		I _{DD}	_	No load, no input		_	0.3	1.5	mA
Operating supply current (2)		I _{DR}	_	No load, output V _{OL} level		_	2.3	3.5	mA
Input voltage	"H" level	V _{IH (1)}		CMOS input termin <u>al</u> DIN, CLK, LS, CG, CL		V _{DD} ×0.7	~	V _{DD}	V
	"L" level	V _{IL (1)}				GND	~	V _{DD} ×0.3	
Input voltage	"H" level	V _{IH (2)}	_	3–value input terminal AD1, AD2		V _{DD} -0.5	~	V _{DD}	V
	Open	V _{IM}				_	V _{DD} ×0.5	_	
	"L" level	V _{IL (2)}				GND	~	GND +0.5	
Input	"H" level	I _{IH}	_	CMOS input terminal	V _{IH} = 5V	-1.0	~	1.0	- μΑ
current	"L" level	I _{IL}			V _{IL} = 0V	-1.0	~	1.0	
Input resistance		R _{IN}	_	3-value input terminal		80	100	120	kΩ
Output	"H" level	I _{OH} (1)	_	HVO-1~-20 output terminal	V _{OH} = 45V		-8.4	-5	- mA
current	"L" level	I _{OL (1)}			V _{OL} = 3V	2.0	2.7	_	
Output	"H" level	I _{OH} (2)	_	DO output terminal	V _{OH} = 4V	_	-0.3	-0.1	- mA
current	"L" level	I _{OL} (2)			V _{OL} = 1V	0.1	0.3	_	
Clock frequence	СУ	f _{CLK}		CLK max. operating			5.0	4.0	MHz
Clock pulse width		t _{wc}		CLK min. operating		75	60	_	ns
Data setup time		t _{ds}	Fig. 1	DIN min. operating pulse width		50	40	_	ns
Data hold time		t _{dh}				50	40	_	ns
LS pulse width		t _{wl}]	LS min. operating		80	60	_	ns
CLK-LS delay time		t _{dc}		CLK→LS delay time		50	40	_	ns
CLK-DOUT delay time		t _{pd}		CLK→DOUT delay time CL = 30pF		_	120	160	ns

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Fig. 1: Serial data timing chart

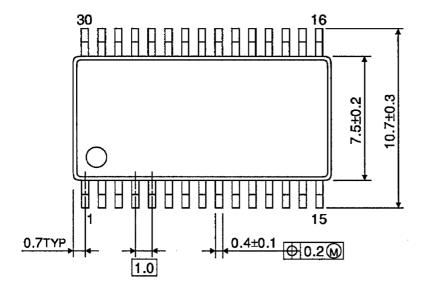


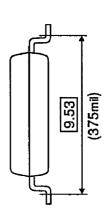
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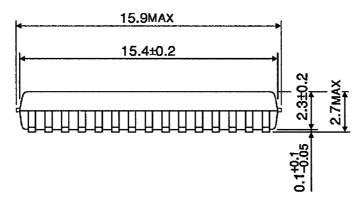
Unit: mm

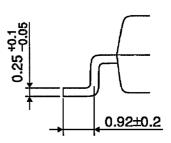
Package Dimensions

SSOP30-P-375-1.00









Weight: 0.7g (typ.)

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